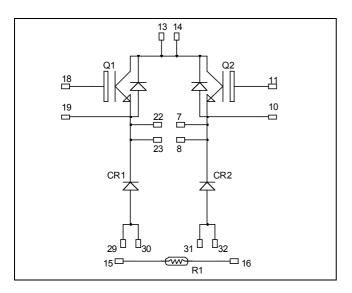
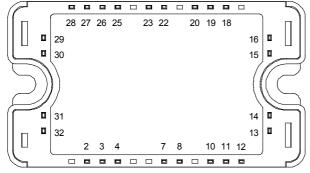


# Dual Buck chopper NPT IGBT Power Module

$$V_{CES} = 1200V$$
  
 $I_{C} = 25A$  @  $Tc = 80$ °C





All multiple inputs and outputs must be shorted together Example: 13/14; 29/30; 22/23...

### Application

- AC and DC motor control
- Switched Mode Power Supplies

#### **Features**

- Non Punch Through (NPT) Fast IGBT
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 50 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
  - Symmetrical design
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCEsat
- Each leg can be easily paralleled to achieve a single buck of twice the current capability.
- RoHS compliant

#### **Absolute maximum ratings**

Symbol	Parameter		Max ratings	Unit
$V_{CES}$	Collector - Emitter Breakdown Voltage		1200	V
$I_{\mathrm{C}}$	$T_{\rm C} = 25$		40	
1 <sub>C</sub>	Continuous Collector Current	$T_C = 80^{\circ}C$	25	Α
$I_{CM}$	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
$V_{GE}$	Gate – Emitter Voltage		±20	V
$P_{\mathrm{D}}$	Maximum Power Dissipation	$T_C = 25^{\circ}C$	208	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125$ °C	50A@1150V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



### All ratings @ $T_j = 25$ °C unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
1	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_j = 25^{\circ}C$			250	μA
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{CE} = 1200V$	$T_j = 125$ °C			500	μΛ
V	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C	2.5	3.2	3.7	V
$V_{CE(sat)}$	Confector Emitter Saturation Voltage	$I_C = 25A$	$T_j = 125$ °C		4.0		V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 1 \text{mA}$		4		6	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

**Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			1650		
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$			250		pF
$C_{res}$	Reverse Transfer Capacitance	f = 1MHz			110		
$Q_{g}$	Total gate Charge	$V_{GE} = 15V$			160		
$Q_{ge}$	Gate – Emitter Charge	$V_{Bus} = 600V$			10		nC
$Q_{gc}$	Gate – Collector Charge	$I_C=25A$			70		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	ning (25°C)		60		
$T_{\rm r}$	Rise Time		$V_{GE} = 15V$		50		ns
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 600V$ $I_{\text{C}} = 25A$			305		
$T_{\mathrm{f}}$	Fall Time	$R_G = 22\Omega$		30			
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	ning (125°C)		60		
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 25A$	$V_{Bus} = 600V$		346		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 22\Omega$			40		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 600V$	$T_j = 125$ °C		3.5		I
$E_{\text{off}}$	Turn-off Switching Energy	$I_C = 25A$ $R_G = 22\Omega$	$T_j = 125$ °C		1.5		mJ

Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit	
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			1200			V	
$I_{RM}$	Maximum Reverse Leakage Current	:   V <sub>D</sub> =1200V	$V_{p}=1200V$	$T_j = 25^{\circ}C$			250	μA
1RM	Waximum Reverse Leakage Current			$T_j = 125$ °C			500	μπ
$I_F$	Forward Current		$Tc = 70^{\circ}C$		60		A	
	Diode Forward Voltage	$I_F = 60A$			2	2.5		
$V_{\mathrm{F}}$		$I_F = 120A$			2.3		V	
		$I_F = 60A$	$T_j = 125$ °C		1.8			
+	Danisha Danisha Tima	I - 604	$T_j = 25$ °C		400		200	
t <sub>rr</sub>	Reverse Recovery Time		$T_j = 125$ °C		470		ns	
$Q_{rr}$	Reverse Recovery Charge	$di/dt = 200 A/\mu s$	$T_j = 25^{\circ}C$		1.2		μС	
<b>V</b> rr			$T_{j} = 125^{\circ}C$		4		μС	



 $Temperature\ sensor\ NTC\ (\text{see application note APT0406 on www.microsemi.com for more information}).$ 

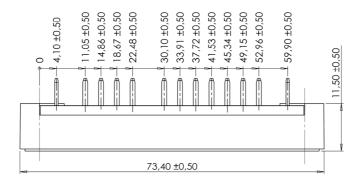
	Symbol	Characteristic	Min	Тур	Max	Unit
	R <sub>25</sub>	Resistance @ 25°C		50		kΩ
I	B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

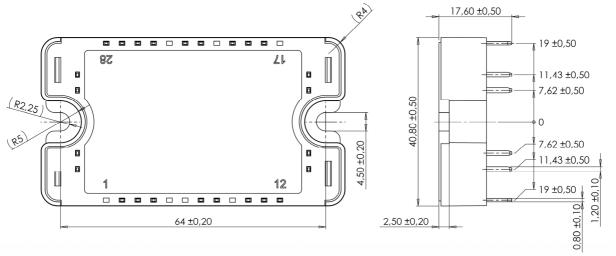
$$R_{T} = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{75}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$
 
$$R_{T}: \text{ Thermistor value at T}$$

Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
$R_{thJC}$	Junction to Case Thermal Resistance		IGBT			0.6	°C/W
1\(\text{thJC}\)			Diode			0.9	C/ VV
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz		4000			V	
$T_{J}$	Operating junction temperature range		-40		150		
$T_{STG}$	Storage Temperature Range		-40		125	°C	
$T_{\rm C}$	Operating Case Temperature		-40		100		
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight		•			110	g

### SP3 Package outline (dimensions in mm)

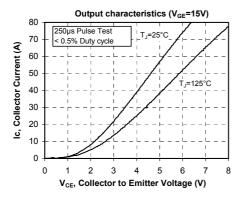


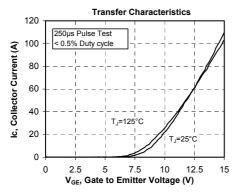


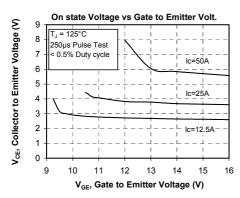
See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

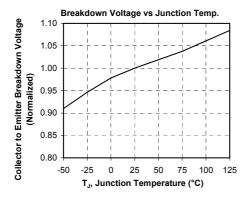


### **Typical Performance Curve**

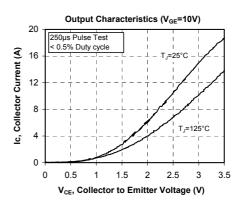


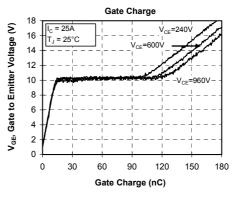


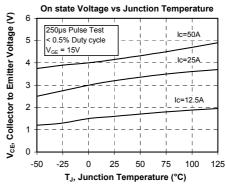


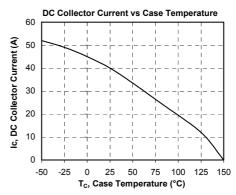


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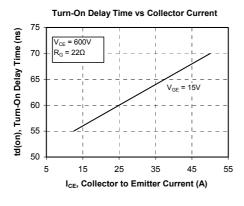


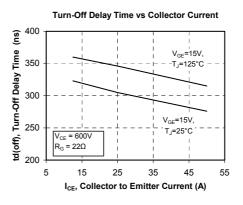


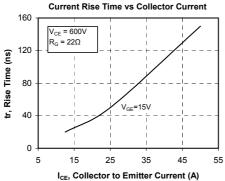


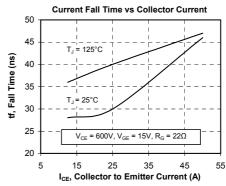


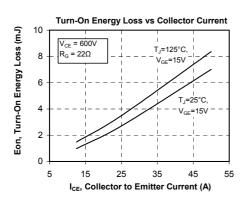


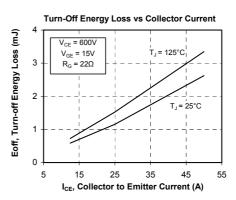


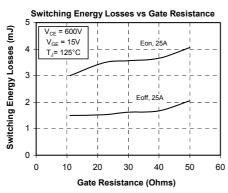


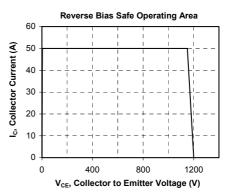




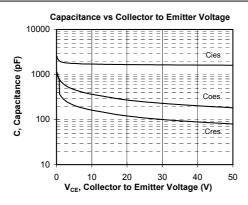


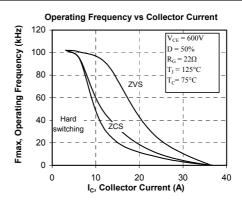


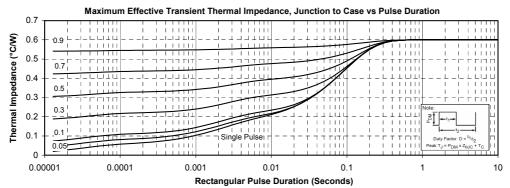












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